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# Structural and magnetic properties of He<sup>+</sup> irradiated Co<sub>2</sub>MnSi heusler alloys

I. Abdallah<sup>1</sup>, N. Ratel-Ramond<sup>1</sup>, C. Magen<sup>2,3</sup>, B. Pecassou<sup>1</sup>, R. Cours<sup>1</sup>, A. Arnoult<sup>4</sup>, M. Respaud<sup>5</sup>, J.F. Bobo<sup>1</sup>, G. BenAssayag<sup>1</sup>, E. Snoeck<sup>1</sup> and N. <u>Biziere<sup>1</sup></u>.

CEMES-CNRS, UPR 8011, Université de Toulouse, 29 rue Jeanne Marvig, BP 94347,
 31055 Toulouse Cedex 04, France.

2. LMA, INA-ARAID, and Departamento de Fisica de la Materia Condensada, Universidad de Zaragoza, 50018 Zaragoza, Spain.

3. 3. TALEM, CEMES-INA, CNRS-Universidad de Zaragoza, 31055 Toulouse Cedex 04, France

4. CNRS, LAAS, F-31000 Toulouse, France.

6. Laboratoire de Physique et Chimie des Nano-Objets, LPCNO, UMR 5215 INSA-UPS-CNRS, Université de Toulouse; 135 avenue de Rangueil, 31077 Toulouse, France.

Contact Author : <u>nicolas.biziere@cemes.fr</u>

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<u>Abstract</u>: We have investigated the atomic disorder induced by a 150 keV He<sup>+</sup> ion irradiation in a 40 nm thick  $Co_2MnSi$  Heusler alloy. Disorder parameters on each atomic site are deduced from normal and anomalous X-ray diffraction measurements with Co and Cu K $\alpha$  sources. While the film grows mainly in the L2<sub>1</sub> phase with inclusion of B2 grains, we observe an increase of both the Mn-Si and Co-Mn exchanges with the ion fluence. HAADF-STEM analysis demonstrates that the increase in Mn-Si disorder corresponds to a growing size of the B2 grains while the Co-Mn exchange is accounted for a D0<sub>3</sub> disorder type in the L2<sub>1</sub> matrix. These structural modifications are shown to decrease the

average magnetization of the alloy, which is due to  $DO_3$  disorder and local defects induced by irradiation.

#### I. Introduction

In the last ten years, full Heusler compounds with general formula  $X_2YZ$  have become a major topic in spintronics, especially for spin torque devices requiring low damping and high spin polarization. Among them, Co<sub>2</sub>MnSi (CMS) is a very promising candidate. It is predicted to be half metallic, with a Curie temperature well above the room temperature [1-4] and a very low Gilbert damping coefficient as compared to other ferromagnetic metals [5,6].

In all Heusler alloys, the magnetic properties and the atomic order are intimately related. For example, half metallicity has been predicted in CMS for the  $L2_1$  or B2 structure only [7]. The  $L2_1$  structure is the most ordered phase and corresponds to 8 body centered cubic (bcc) sub-lattices having the Co atoms at the corners of the bcc cells and the center sites occupied either by the Mn or Si atoms. A random distribution between Mn and Si or between Mn and Co atoms corresponds to the B2 or D0<sub>3</sub> order respectively while a random distribution of the Co, Mn and Si atoms between the different atomic sites leads to the disordered A2 phase.

Ion irradiation with light ions is an efficient technique to improve the local chemical order in different magnetic alloys such as FePt [8] or more recently in Heusler alloy [9]. Indeed, Gaier et al. demonstrated that He<sup>+</sup> ion irradiation at 30 keV increases the long range order parameter in CMS grown in the B2 phase. Therefore, ion irradiation appears as a very interesting complementary or alternative technique to high temperature annealing, incompatible with microelectronic processes. Before this, further studies about the structural modification induced by irradiation are needed. In this work, we offer to study the structural modification in both the L2<sub>1</sub> and B2 order in Co<sub>2</sub>MnSi irradiated with 150 keV He<sup>+</sup> ions.

Several techniques can be used to characterize the crystal structure such as neutron diffraction, nuclear magnetic resonance, X-ray absorption and circular magnetic dichroism (XAS/XMCD), photoemission spectroscopy (HAXPES) or HAADF-STEM techniques [10-13]. However, X-ray diffraction is an accessible and commonly used technique for macroscopic characterization of the crystal order [14-16]. Quantitative information on the presence of the different phases can be extracted from the measurements of the intensity of different diffraction peaks. For example, superlattice (h,k,l) diffraction peaks for which with h, k and l are odd numbers (e.g. 111) only appear when the L2<sub>1</sub> and/or D0<sub>3</sub> phases are present while diffraction peaks for which h+k+l = 4n+2 (e.g. 002) appear for L2<sub>1</sub>, D0<sub>3</sub> and B2 phases. Finally, the fundamental peaks whose h+k+l = 4n (e.g. 022) appear for all crystal phases.

One of the major issues encountered in X-ray diffraction experiments to discriminate between the various ordered phases in CMS is that the Co and Mn scattering factors are very close at the Cu K $\alpha$  edge, making it almost impossible to distinguish between D0<sub>3</sub> and L2<sub>1</sub> phases. This issue can however be overpassed using a Co-K $\alpha$  source because, due to anomalous diffraction of the Co at the K-edge, the Co and Mn scattering factors becomes very different and Co and Mn atoms can be differentiated.

Thus, the different disorder parameters in CMS can be obtained combining diffraction measurements using Cu and Co K $\alpha$  sources. The method, based on a model proposed by Niculescu et al. [17], has recently been applied by Takamura et al. [18] for the structural characterization of Co<sub>2</sub>FeSi. In this model  $\alpha$ ,  $\beta$  and  $\gamma$  are three disorder parameters.  $\alpha$  corresponds to the number of Mn atoms located on Si sites and then represents the Mn/Si substitution per CMS unit. Similarly,  $\beta$  and  $\gamma$  corresponds to the number of Co atoms on Si and Mn sites respectively. Then, the structure factors for the different peak of interest are expressed as:

$$F_{111} \propto (1 - 2\alpha - \beta)(f_{Mn} - f_{Si}) + (\gamma - \beta)(f_{Co} - f_{Mn})$$
(1)

$$F_{002} \propto (1 - 2\beta)(f_{Co} - f_{Si}) + (1 - 2\gamma)(f_{Co} - f_{Mn})$$
<sup>(2)</sup>

$$F_{022} \propto 2f_{C0} + f_{Mn} + f_{Si}$$
 (3)

where  $f_{Co}$ ,  $f_{Mn}$  and  $f_{Si}$  are the scattering factors calculated from Ref [19]. We can see from eq. 1 and 2 that if  $f_{Co}$  and  $f_{Mn}$  are close, as for Cu K $\alpha$  source, the intensity of the diffraction peaks  $I_{111}$  ( $\infty |F_{111}|^2$ ) and  $I_{002}$  ( $\infty |F_{002}|^2$ ) are not sensitive to D0<sub>3</sub> order while it is for Co-K $\alpha$  source in anomalous conditions.

#### I. Experimental details.

In this study CMS have been grown by magnetron sputtering on MgO (001) single crystals in a Plassys MPU 600 S ultrahigh vacuum (UHV) chamber. Details about the deposition conditions are presented in Ref [20]. The thickness of the CMS layer is  $42 \pm -1$  nm and a 10 nm MgO capping layer is deposited to avoid oxidation. This reference sample is then cut into four pieces, one as a reference and three for He<sup>+</sup> irradiation at 150 keV performed with a 200A2 Varian ion implanter. The irradiation is performed at room temperature and the fluences for the three samples are  $1 \times 10^{15}$ ,  $5 \times 10^{15}$  and  $1 \times 10^{16}$  ions per cm<sup>2</sup> respectively. The high kinetic energy of the ions prevents from implantation of He<sup>+</sup> in the CMS film as they stop several hundreds of nm deep in the substrate.

X-ray diffraction experiments were performed on a Bruker D8-Discover (Da-Vinci) diffractometer equipped with a Cu K $\alpha_1$  source ( $\lambda$ =0.154 nm) to measure the (002) and (004) peaks while a Panalytical Empyrean diffractometer equipped with a Co K $\alpha_1$  source ( $\lambda$ =0.179 nm) has been used to measure the (111), (002) and (022) diffraction peaks. Note that the (004) and (022) peaks

show similar structure factor and are both 'fundamental' peaks. Figure 1 presents examples of different diffraction peaks obtained either with Co or Cu K $\alpha_1$  sources.

#### II. Results and discussion.

According to eq 2 and 3, comparing the experimental  $I_{002}/I_{004}$  ratio to the calculated one allows the extraction of the  $\beta$  values. Then  $\alpha$  and  $\gamma$  are deduced from the measurements of the  $I_{002}/I_{022}$  and  $I_{111}/I_{022}$  ratios.

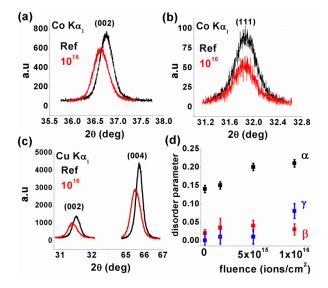


Figure 1. (color online) (002) (a) and (111) (b) diffraction peak at Co K $\alpha_1$  edge for reference (black) and  $10^{16}$  ions/cm<sup>2</sup> irradiated (red) samples. (c) (002) and (004) diffraction peaks at Cu K $\alpha_1$  edge. (d) Disorder parameters obtained from X-ray diffraction experiments.

The results for the deduced  $\alpha$ ,  $\beta$ ,  $\gamma$  are presented in Figure 1.d. For all the samples, we observe that the  $\beta$  parameter, i.e. Co/Si disorder, remains almost constant (0.04 +/- 0.02) whatever the ion fluence. Additionally  $\alpha$  increases from 0.14 +/- 0.01 to 0.22 +/- 0.01 for the reference sample and the 10<sup>16</sup> irradiated one respectively. While we already observe a small increase of  $\alpha$  for 1x10<sup>15</sup> ions/cm<sup>2</sup>, there is a clear step at 5x10<sup>15</sup>. Similarly the  $\gamma$  parameter, i.e. Co/Mn disorder, increases significantly for fluences above 5x10<sup>15</sup>. For lower fluences, the Co-Mn substitution ( $\gamma$ ) is not detectable within the uncertainty of the measurements, meaning it is less than 0.02.

Using these disorder parameters one can calculate the probability of presence of the different atoms on their original site considering the  $L2_1$  phase as starting structure (see details in Ref 18). We

found values of 98, 86 and 83 % for the Co, Mn and Si respectively for the reference sample. These probabilities fall down to 93, 71 and 75% at  $10^{16}$  ions/cm<sup>2</sup>. Considering that  $\alpha = 0.5$  for full B2 order, we can estimate that our sample grows as mixture of L2<sub>1</sub> and B2 phases, with ratios of about 25% of B2 and 75% of L2<sub>1</sub> order (neglecting the small amount of Co/Si disorder).

We also observe structural modifications of the alloy for fluences above  $5.10^{15}$  /cm<sup>2</sup>. The 002 and 004 diffraction peaks of the irradiated sample in Figure 1 are slight shifted toward low angle compared to the peak position of the reference sample, indicating an increase of the out-of-plane lattice parameter from 5.67 to 5.69 Å. In contrary the (111) reflection remains at the same Bragg angle. As the (111) peak is related to the L2<sub>1</sub> and/or D0<sub>3</sub> phases only, we may assume that only regions of the thin film presenting the B2 order have their out-of-plane lattice parameter increasing with the irradiation.

While X-ray diffraction gives macroscopic information about the structural order, it does not explain the way the different atomic exchanges get organized in the material. For example, it is difficult to know if the B2 and D0<sub>3</sub> disorders are diluted in the initial matrix or if grains of a particular ordered phase grow from the L2<sub>1</sub> starting structure. To answer this question we performed HAADF-STEM experiments which provide information on the local ordering at the atomic scale. Measurements have been performed at 300 kV on an FEI Titan 60-300 microscope, equipped with a spherical aberration corrector for the probe. Two lamellas have been prepared by FIB, one extracted from the reference sample and the other one prepared from the sample irradiated at  $10^{16}$  ions/cm<sup>2</sup>. HAADF-STEM studies were realized in the [-110] zone axis. In this orientation and for L2<sub>1</sub> order, the intensity of each atomic column, which increases with Z, corresponds to only one type of atoms.

Figure 2.a shows an example of a HAADF-STEM image obtained on the reference sample. The insert shows a zoom on few atomic columns. Figure 2.b shows the intensity profiles of STEM image taken along different lines reported in Figure2.a. The profiles clearly shows the alternation of high and low peak intensity corresponding to Mn (Z = 25) and Si (Z = 14) columns, demonstrating the L2<sub>1</sub> order. We also note that the difference of intensity between Co and Mn columns is weak as expected from the Co and Mn atomic numbers ( $Z_{Co} = 27$ ). Similarly to classical X-ray diffraction using a Cu K $\alpha$  source, HAADF-STEM is not very sensitive to D0<sub>3</sub> disorder.

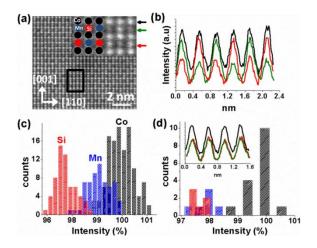


Figure 2. (color online) (a) HAADF-STEM image of CMS. The insert at top right is a zoom over 6x6 atomic columns. (b) Intensity profile of the lines denoted by the colored arrows in (a). (c) Statistical analysis of intensity profile obtained from (a) on a region of 11 x 23 atomic columns. (d) statistical analysis of the area denoted by the black box in (a). In insert the intensity profile of the three central lines in the black box.

In order to demonstrate that the  $L2_1$  order is the main phase of the sample we performed a statistical analysis of maximum peak intensities of the HAADF-STEM images for the reference sample (Figure 2) and for the sample irradiated at  $10^{16}$  ions/cm<sup>2</sup> (Figure 3). For the first one, three distinct intensity distributions corresponding to the Co, Mn and Si atomic columns are observed (Figure 2.c). The values are normalized by the value of the Co intensity at the center of the Co distribution. The appearance of three different intensities in the HAADF-STEM image is in good agreement with the L2<sub>1</sub> order even if some spreading of the intensity distribution is observed. One source of spreading comes from the slight change of thickness across the lamella prepared for STEM experiment. This effect prevents any statistics over very large areas.

In some particular regions of the film other intensity distribution are observed, as the one reported in Figure 2.d which corresponds to statistical analysis performed in the black box in Figure 2.a. The inset in Figure 2.d shows that STEM intensities corresponding to the Mn and Si columns are very similar. Even if the statistical analysis is performed on a small number of atomic columns, it clearly shows that the STEM intensities corresponding to Mn and Si atomic columns converge to a single value, which could be associated to the appearance of the B2 order. This result indicates that very small grains with B2 order are distributed in the L2<sub>1</sub> matrix.

While the B2 order in the reference sample is only observed in small regions of similar size as the black box in Figure 2.a, it can be observed in more extended areas for a fluence of  $10^{16}$  ions/cm<sup>2</sup>. This is shown in Figure 3.a. The B2 order can be observed either from the intensity profile of the different

lines (Figure 3.b) or statistically over the selected area (Figure 3.c). Similar values for the STEM intensity of the Mn and Si columns are measured while the intensity corresponding to the Co columns remains higher. On other part of the sample we still observe the  $L_{2_1}$  order (Figure 3.d). We then suggest that ion irradiation induces a  $L_{2_1}$  to B2 transformation, which occurs around the initial B2 grains.

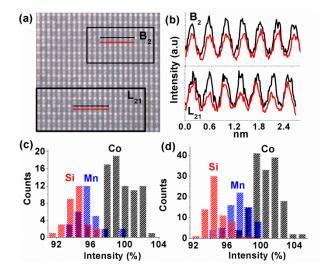


Figure 3. (color online) (a) HAADF-STEM image of CMS irradiated at  $10^{16}$  ions/cm<sup>2</sup>. The black boxes correspond to a zone with B2 or L2<sub>1</sub> character. (b) Intensity profile of the lines denoted by red and black lines in the B2 or L2<sub>1</sub> boxes in (a). Statistical analysis of the B2 (c) and L2<sub>1</sub> (d) regions in (a).

We also observe for the irradiated sample that the relative STEM intensity of the different atomic columns spread over slightly larger values as compared to the reference sample. The most probable explanation relies on the difference between the two prepared samples, especially the thicknesses which modify the absolute STEM intensity. Another possibility relies on local defects such as vacancies induced by the irradiation.

As already explained, it is very challenging to state about any Co/Mn exchange from HAADF-STEM experiments. However one can argue that if Co/Mn substitutions arise in the B2 phase, one should observe a spreading of the STEM intensity associated to the Mn columns that range between Si and Co ones. This is however not what is observed. Moreover, the relative intensity of the Mn columns compared to the Co ones in the L2<sub>1</sub> phase shows similar values (as for the reference sample). Therefore we assume that the D0<sub>3</sub> order most probably arises in the L2<sub>1</sub> matrix.

Finally, we measured the magnetization of the four samples (Figure 4) with a QUANTUM design PPMS VSM magnetometer at 300 K. We clearly observe a decrease of the magnetization versus the ion fluence. As demonstrated in Ref [2] the B2 and L2<sub>1</sub> phase have the same magnetic moment ( $\mu_0$ Ms  $\approx 1.25$  T) while it decreases by 10% in the D0<sub>3</sub> phase. Therefore we argue the decrease of the

magnetization can be accounted for the local Co-Mn exchange in the  $L2_1$  matrix and vacancies induced by the irradiation.

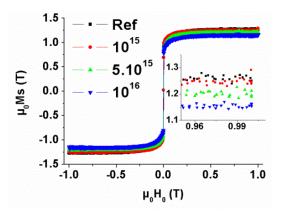


Figure 4. (color online) Evolution of the CMS average magnetization at 300 K as a function of the He<sup>+</sup> fluence.

#### III. Conclusions.

In conclusion we demonstrated that  $He^+$  ion irradiation at 150 keV induces Mn/Si exchange and then favors the B2 structure at the cost of the L2<sub>1</sub> phase. However, for fluences above  $5x10^{15}$  ions/cm<sup>2</sup>, the out of plane lattice parameter of the B2 phase increase and might have an impact upon half metallicity. In addition, for this threshold value, Co/Mn substitution occurs in the L2<sub>1</sub> structure leading to a decreased magnetization and so half metallicity. Below this threshold, no significant improvement of L2<sub>1</sub> order has been observed. Therefore our study demonstrates that ion irradiation is an interesting alternative to annealing only for the B2 order as long as fluence is kept under a threshold value.

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